

ON Semiconductor®

## FDG313N

## **Digital FET, N-Channel**

## **General Description**

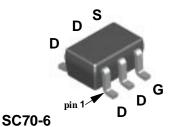
This N-Channel enhancement mode field effect transistor is produced using Fairchild's proprietary, high cell density, DMOS technology. This very high density process is especially tailored to minimize on-state resistance. This device has been designed especially for low voltage applications as a replacement for bipolar digital transistor and small signal MOSFET.

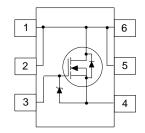
### **Applications**

- Load switch
- Battery protection
- Power management

### **Features**

- 0.95 A, 25 V.  $R_{DS(on)} = 0.45~\Omega$  @  $V_{GS} = 4.5~V$   $R_{DS(on)} = 0.60~\Omega$  @  $V_{GS} = 2.7~V$ .
- Low gate charge (1.64 nC typical)
- Very low level gate drive requirements allowing direct operation in 3V circuits (V<sub>GS(th)</sub> < 1.5V).</li>
- Gate-Source Zener for ESD ruggedness (>6kV Human Body Model).
- Compact industry standard SC70-6 surface mount package.





Absolute Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

Symbol	Parameter		FDG313N	Units
V <sub>DSS</sub>	Drain-Source Voltage		25	V
V <sub>GSS</sub>	Gate-Source Voltage		<u>±</u> 8	V
I <sub>D</sub>	Drain Current - Continuous	(Note 1a)	0.95	Α
	- Pulsed		2	
$P_D$	Power Dissipation for Single Operation	(Note 1a)	0.75	W
		(Note 1b)	0.55	
		(Note 1c)	0.48	
T <sub>J</sub> , T <sub>stg</sub>	Operating and Storage Junction Temperature Range		-55 to +150	°C
ESD	Electrostatic Discharge Rating MIL-STD-883D Human Body Model (100pf / 1500 Ohm)		6	kV

### **Thermal Characteristics**

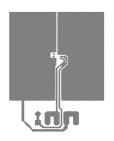
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$R_{\theta^{JA}}$	Thermal Resistance, Junction-to-Ambient	(Note 1c)	260	∘C/W

Package Outlines and Ordering Information

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Device Marking	Device	Reel Size	Tape Width	Quantity
.13	FDG313N	7"	8mm	3000 units

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	25			V
ΔBVDSS ΔTJ	Breakdown Voltage Temperature Coefficient	$I_D$ = 250 $\mu$ A, Referenced to 25°C		30		mV/∘C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	$V_{DS} = 20 \text{ V}, V_{GS} = 0 \text{ V}$			1	μΑ
I <sub>GSS</sub>	Gate-Body Leakage Current	$V_{GS} = 8 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
On Char	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250  \mu A$	0.65	0.8	1.5	V
ΔVGS(th) ΛTJ	Gate Threshold Voltage Temperature Coefficient	I <sub>D</sub> = 250 μA, Referenced to 25°C		-2		mV/°C
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 4.5 \text{ V}, I_D = 0.5 \text{ A}$ $V_{GS} = 4.5 \text{ V}, I_D = 0.5 \text{ A} @ 125 ^{\circ}\text{C}$ $V_{GS} = 2.7 \text{ V}, I_D = 0.2 \text{ A}$		0.35 0.53 0.45	0.45 0.76 0.6	Ω
I <sub>D(on)</sub>	On-State Drain Current	$V_{GS} = 4.5 \text{ V}, V_{DS} = 5 \text{ V}$	0.5			Α
<b>g</b> <sub>FS</sub>	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 0.5 \text{ A}$		1.5		S
Dynamic	Characteristics					
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz		50		pF
C <sub>oss</sub>	Output Capacitance			28		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			9		pF
Switchin	ng Characteristics (Note 2)			•		•
t <sub>d(on)</sub>	Turn-On Delay Time	$V_{DD} = 6 \text{ V}, I_D = 0.5 \text{ A},$		3	6	ns
t <sub>r</sub>	Turn-On Rise Time	$V_{GS} = 4.5 \text{ V}, R_{GEN} = 50 \Omega$		8.5	18	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	1		17	30	ns
t <sub>f</sub>	Turn-Off Fall Time			13	25	ns
$Q_g$	Total Gate Charge	$V_{DS} = 5 \text{ V}, I_{D} = 0.95 \text{ A},$ $V_{GS} = 4.5 \text{ V}$		1.64	2.3	nC
Q <sub>gs</sub>	Gate-Source Charge			0.38		nC
$Q_{gd}$	Gate-Drain Charge	7		0.45		nC
Drain Ca	uros Diodo Charastaristica a	and Maximum Patings	•	•	•	•
<u>Drain-Sc</u> Is	Durce Diode Characteristics a  Maximum Continuous Drain-Source				0.6	Α
		$V_{GS} = 0 \text{ V}, I_{S} = 0.6 \text{ A} \text{ (Note 2)}$	1	ļ		V

 $\textbf{1.} \ \ R_{\theta JA} \ \text{is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the large solutions of the sum of the junction of the$ drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta JA}$  is determined by the user's board design.



a) 170°C/W when mounted on a 1 in² pad of 2oz copper.



b) 225°C/W when mounted on a half of package sized 2oz.



c) 260°C/W when mounted on a minimum pad of 2oz copper.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width  $\leq 300~\mu s$ , Duty Cycle  $\leq 2.0\%$ 

# **Typical Characteristics**

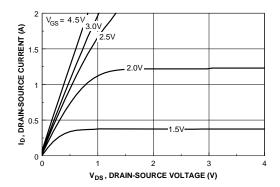


Figure 1. On-Region Characteristics.

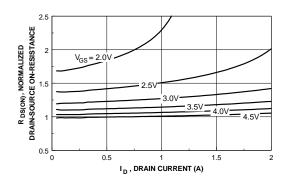


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

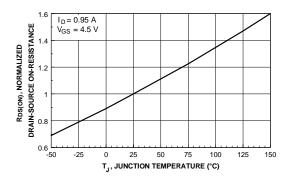


Figure 3. On-Resistance Variation with Temperature.

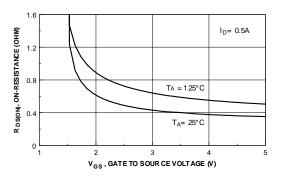


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

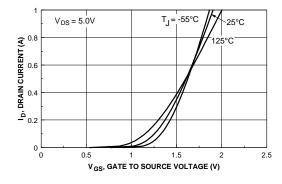


Figure 5. Transfer Characteristics.

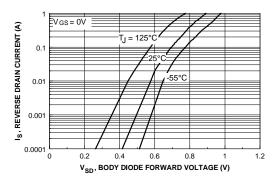
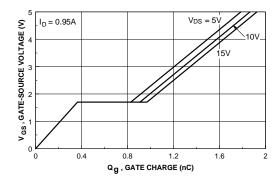


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

## Typical Characteristics (continued)



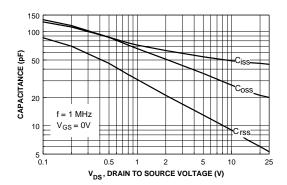
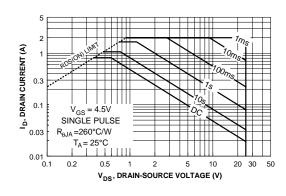


Figure 7. Gate-Charge Characteristics.





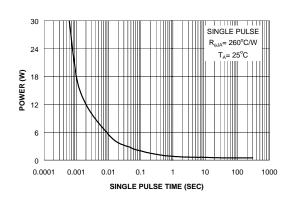


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

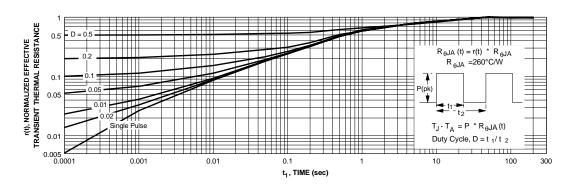


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient themal response will change depending on the circuit board design.

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